## Notice of References Cited

	Application/Control No. 10/789,278	Applicant(s)/Patent Under Reexamination REUS ET AL.		
	Examiner	Art Unit		
ı	DUSTIN NGUYEN	2454	Page 1 of 1	

## II S PATENT DOCUMENTS

U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,116,661	10-2006	Patton, Charles	370/390
*	В	US-7,031,288	04-2006	Ogier, Richard G.	370/338
*	С	US-2005/0060406	03-2005	Zhang et al.	709/225
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

		NOTE ATENT DOGGLETTO
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sylvia Ratnasamy, Mark Handley, Richard Karp, Scott Shenker, "Topologically-Aware Overlay Construction and Server Selection", IEEE Infocom, 2002, 10 pages
	٧	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YY-YY format are publication dates. Classifications may be US or foreign.